TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC7SBD384AFU

### Single Bus Switch with Level Shifting

The TC7SBD384AFU provides single bit of high-speed TTL-compatible switching. The low on resistance of the switch allows connections to be made with minimal propagation delay.

The device is organized as just 1-bit low-impedance switch with output-enable  $(\overline{OE})$  input. When  $\overline{OE}$  is low, the switch is on and data can flow from port A to port B, or vice versa. When  $\overline{OE}$  is high, the switch is open and a high-impedance state exists between the two ports.

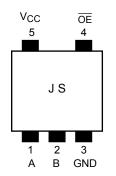
The device is enable to realize the shift of signal level from 5 V to 3.3 V.

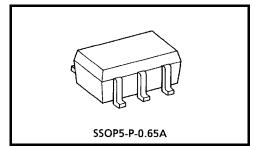
All inputs are equipped with protection circuits against static discharge.



- Operating voltage: V<sub>CC</sub> = 4.5~5.5 V
- High speed operation:  $t_{pd} = 0.32 \text{ ns} (\text{max})$
- Low on resistance:  $R_{ON} = 5 \Omega$  (typ.)
- ESD performance: Machine model  $\ge \pm 200 \text{ V}$ Human body model  $\ge \pm 2000 \text{ V}$
- TTL level input (control input)
- Low Power Dissipation: Icc =  $10 \ \mu A (max.)$
- Package: USV

### Pin Assignment (top view)





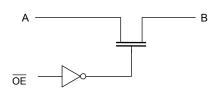
Weight: 0.006 g (typ.)

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#### Truth Table

Input	Function		
OE	Function		
L	A port = B port		
Н	Disconnect		

## System Diagram



# Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Power supply range	V <sub>CC</sub>	-0.5~7.0	V
DC input voltage	V <sub>IN</sub>	-0.5~7.0	V
DC switch voltage	VS	-0.5~7.0	V
Input diode current	I <sub>IK</sub>	-50	mA
Continuous channel current	IS	128	mA
Power dissipation	PD	200	mW
DC V <sub>CC</sub> /GND current	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA
Storage temperature	T <sub>stg</sub>	-65~150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

### **Operating Ranges (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage	V <sub>CC</sub>	4.5~5.5	V
Input voltage	V <sub>IN</sub>	0~5.5	V
Switch voltage	VS	0~5.5	V
Operating temperature	T <sub>opr</sub>	-40~85	°C
Input rise and fall time	dt/dv	0~10	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device.

### **Electrical Characteristics**

#### DC Characteristics (Ta = -40~85°C)

Charac	teristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Typ. (Note 1)	Max	Unit
Input voltage	"H" level	VIH	_		4.5~5.5	2.0	—	_	v
Input voltage	"L" level	VIL			4.5~5.5	_		0.8	v
Llich lovel outr	t.valtaga				4.75	2.3	2.8	3.2	
High-level outp	(Note 2)	V <sub>OH</sub>	IOH=-1μA		5.0	2.5	3.0	3.4	V
	(NOLE 2)		$V_{IS} = V_{CC}$		5.25	2.7	3.2	3.6	
Input leakage of	current	I <sub>IN</sub>	V <sub>IN</sub> = 0~5.5 V		4.5~5.5	_	—	±1.0	μA
Power off leaka	age current	IOFF	A, B, $\overline{OE}$ = 0~5.5 V		0	_	—	±1.0	μA
Off-STATE lea (switch off)	kage current	I <sub>SZ</sub>	A, B = 0~5.5 V, OE =	V <sub>CC</sub>	4.5~5.5	_	_	±1.0	μΑ
				h. 64 mA	4.5		5	9	
			V <sub>IS</sub> = 0 V	I <sub>IS</sub> = 64 mA	4.75	_	5	8	
ON resistance		Bass	VIS = 0 V	1.a 20 mA	4.5	_	5	9	Ω
	(Note 3)	R <sub>ON</sub>		I <sub>IS</sub> = 30 mA	4.75	_	5	8	52
	)/ 22)/ 15 mA		4.5	_	35	65			
			$V_{IS} = 2.3 \text{ V}, I_{IS} = 15 \text{ m}.$	•	4.75	_	35	50	
Quiescent supp	oly current	ICC	VIN = VCC or GND,I <sub>OUT</sub> = 0		5.5	_	_	10	μA
Increase in I <sub>CC</sub>	; per input	Δlcc	V <sub>IN</sub> = 3.4 V (one input)		5.5			2.5	mA

Note 1: Typical values are at  $V_{CC} = 5 V$ ,  $Ta = 25^{\circ}C$ .

- Note 2: It recommends that this device uses Pull-up resistance when adding and using resistance for an output terminal. Since it couses to drop a VOH voltage level when using Pull-down resistance for an output terminal.
- Note 3: Measured by the voltage drop between A and B pins at the indicated current through the switch. On resistance is determined by the lower of the voltages on the two (A or B) pins.

# AC Characteristics (Ta = -40~85°C)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Propagation delay time	t <sub>pLH</sub>	Figure 1, Figure 2 (Note)	4.5	_	0.32	ns
(bus to bus)	t <sub>pHL</sub>		4.0		0.02	110
Output enable time	t <sub>pZL</sub>	Figure 1, Figure 3	4.5		4.5	ns
	t <sub>pZH</sub>		4.5		4.5	115
Output disable time	t <sub>pLZ</sub>	Figure 1, Figure 3	4.5		4.5	ns
	t <sub>pHZ</sub>		4.5		4.0	115

Note: The propagation delay time is calculated by the RC (on-resistance and load capacitance) time constant.

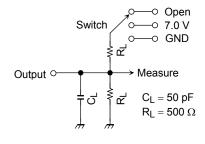
### **Capacitive Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
Control pin input capacitance	C <sub>IN</sub>	(Note)	5.0	3	pF
Switch terminal capacitance	C <sub>I/O</sub>	$\overline{OE} = V_{CC}$ (Note)	5.0	10	pF

Note: This parameter is guaranteed by design.

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# **AC Test Circuit**



Parameter	Switch
t <sub>pLH</sub> , t <sub>pHL</sub>	Open
t <sub>pLZ</sub> , t <sub>pZL</sub>	7.0 V
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND



# AC Waveform

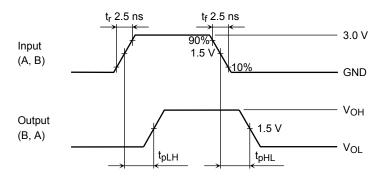


Figure 2 t<sub>pLH</sub>, t<sub>pHL</sub>

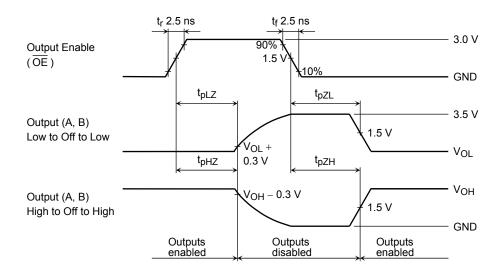


Figure 3  $t_{pLZ}$ ,  $t_{pHZ}$ ,  $t_{pZL}$ ,  $t_{pZH}$ 

# V<sub>OH</sub> – V<sub>CC</sub> Characteristics (typ.)

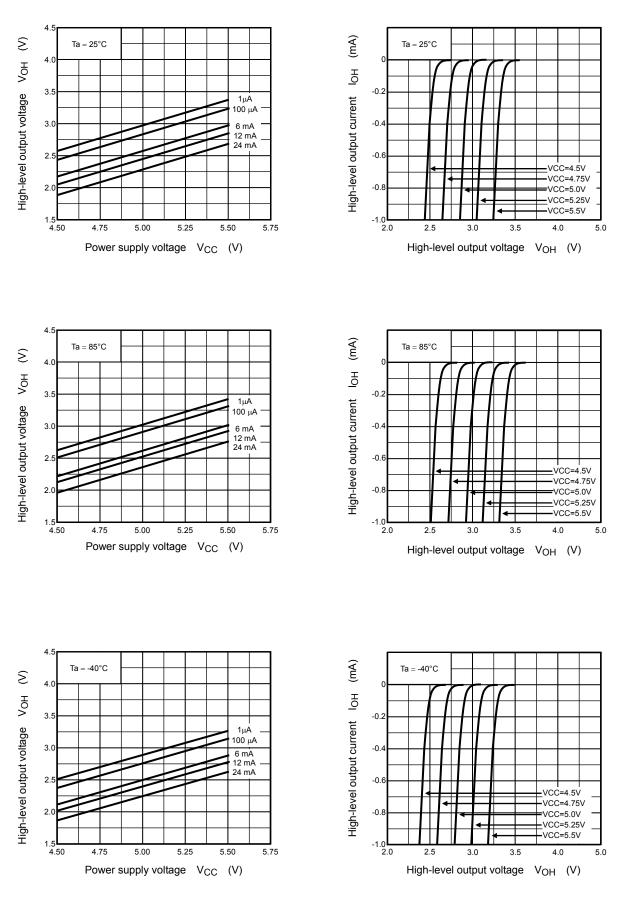
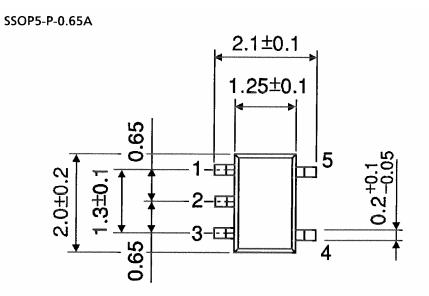
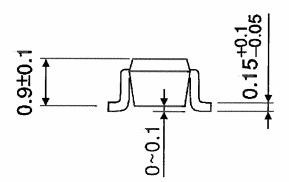


Figure 4

# **TOSHIBA**

# Package Dimensions





Weight: 0.006 g (typ.)

Unit : mm

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20070701-EN GENERAL

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